



N-Channel 20-V (D-S) Fast Switching MOSFET

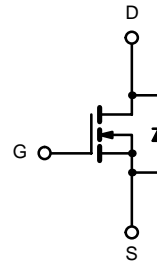
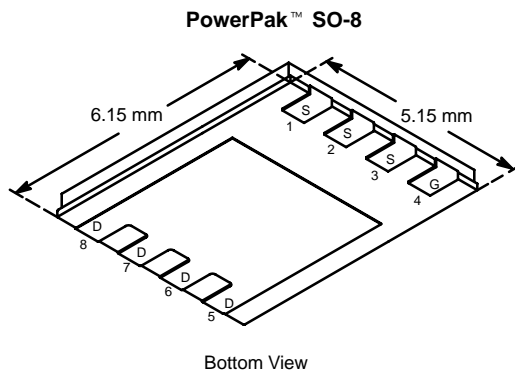
| PRODUCT SUMMARY | | |
|-----------------|---------------------------|-----------|
| V_{DS} (V) | $r_{DS(on)}$ (Ω) | I_D (A) |
| 20 | 0.0065 @ $V_{GS} = 4.5$ V | 22 |
| | 0.009 @ $V_{GS} = 2.5$ V | 19 |

FEATURES

- TrenchFET® Power MOSFET
- New Low Thermal Resistance PowerPAK™ Package with Low 1.07-mm Profile

APPLICATIONS

- Synchronous Rectifier—Low Output Voltage
- Portable Computer Battery Selection or Protection



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED) | | | | |
|---|----------------|--------------------------|--------------|------------------|
| Parameter | Symbol | 10 secs | Steady State | Unit |
| Drain-Source Voltage | V_{DS} | 20 | | V |
| Gate-Source Voltage | V_{GS} | ± 12 | | |
| Continuous Drain Current ($T_J = 150^\circ\text{C}$) ^a | I_D | $T_A = 25^\circ\text{C}$ | 22 | 13.4 |
| | | $T_A = 70^\circ\text{C}$ | 17.6 | 10.7 |
| Pulsed Drain Current | I_{DM} | 50 | | A |
| Continuous Source Current (Diode Conduction) ^a | I_S | 4.3 | 1.6 | |
| Maximum Power Dissipation ^a | P_D | $T_A = 25^\circ\text{C}$ | 5.2 | 1.9 |
| | | $T_A = 70^\circ\text{C}$ | 3.3 | 1.2 |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | -55 to 150 | | $^\circ\text{C}$ |

| THERMAL RESISTANCE RATINGS | | | | |
|--|------------|-----------------|---------|---------------------------|
| Parameter | Symbol | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient ^a | R_{thJA} | $t \leq 10$ sec | 19 | 24 |
| | | Steady State | 52 | 65 |
| Maximum Junction-to-Case (Drain) | R_{thJC} | 1.5 | 1.8 | $^\circ\text{C}/\text{W}$ |

Notes

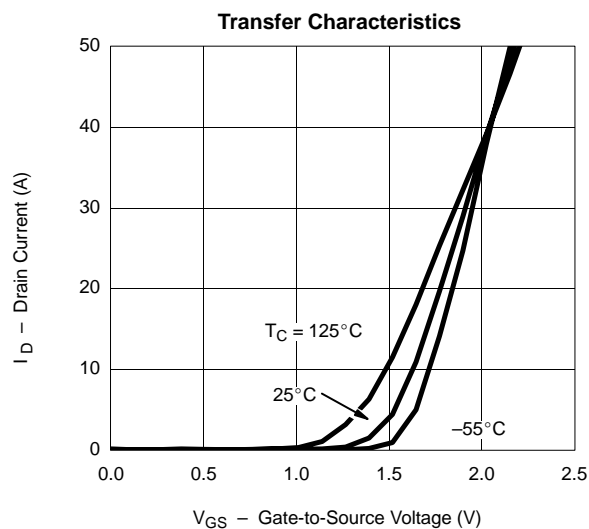
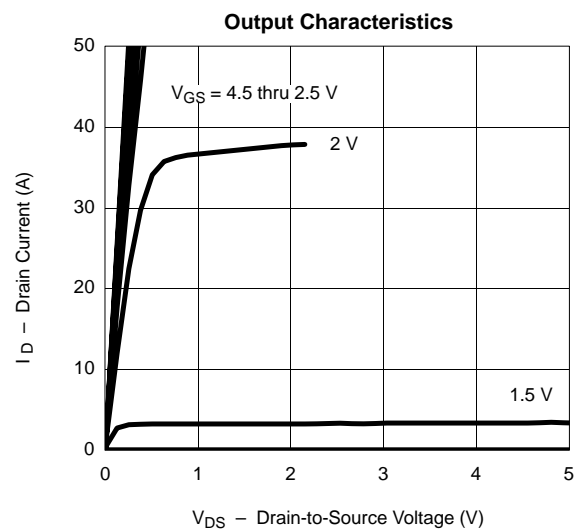
a. Surface Mounted on 1" x 1" FR4 Board.

MOSFET SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

| Parameter | Symbol | Test Condition | Min | Typ | Max | Unit |
|---|--------------|---|-----|--------|-----------|---------------|
| Static | | | | | | |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | 0.6 | | | V |
| Gate-Body Leakage | I_{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μA |
| | | $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^\circ\text{C}$ | | | 20 | |
| On-State Drain Current ^a | $I_{D(on)}$ | $V_{DS} \geq 5 \text{ V}, V_{GS} = 4.5 \text{ V}$ | 50 | | | A |
| Drain-Source On-State Resistance ^a | $r_{DS(on)}$ | $V_{GS} = 4.5 \text{ V}, I_D = 22 \text{ A}$ | | 0.0054 | 0.0065 | Ω |
| | | $V_{GS} = 2.5 \text{ V}, I_D = 19 \text{ A}$ | | 0.0075 | 0.009 | |
| Forward Transconductance ^a | g_{fs} | $V_{DS} = 15 \text{ V}, I_D = 22 \text{ A}$ | | 90 | | S |
| Diode Forward Voltage ^a | V_{SD} | $I_S = 3 \text{ A}, V_{GS} = 0 \text{ V}$ | | 0.8 | 1.2 | V |
| Dynamic^b | | | | | | |
| Total Gate Charge | Q_g | $V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 21 \text{ A}$ | | 38 | 50 | nC |
| Gate-Source Charge | Q_{gs} | | | 8 | | |
| Gate-Drain Charge | Q_{gd} | | | 8.5 | | |
| Gate-Resistance | R_G | | | 0.9 | | Ω |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 10 \text{ V}, R_L = 10 \Omega$ $I_D \cong 1 \text{ A}, V_{GEN} = 10 \text{ V}, R_G = 6 \Omega$ | | 22 | 35 | ns |
| Rise Time | t_r | | | 22 | 35 | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | 125 | 190 | |
| Fall Time | t_f | | | 60 | 90 | |
| Source-Drain Reverse Recovery Time | t_{rr} | $I_F = 3 \text{ A}, di/dt = 100 \text{ A}/\mu\text{s}$ | | 60 | 90 | |

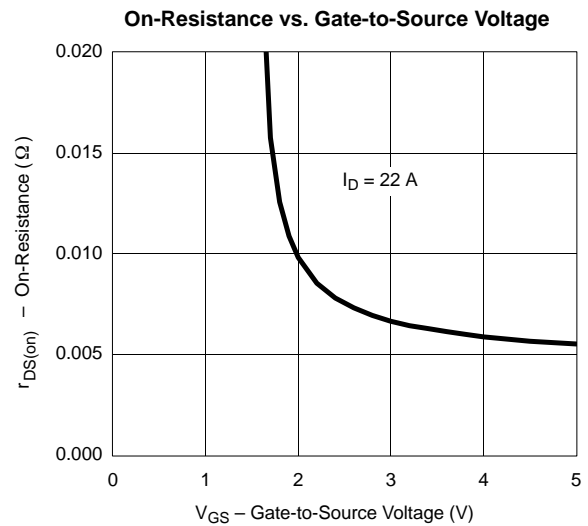
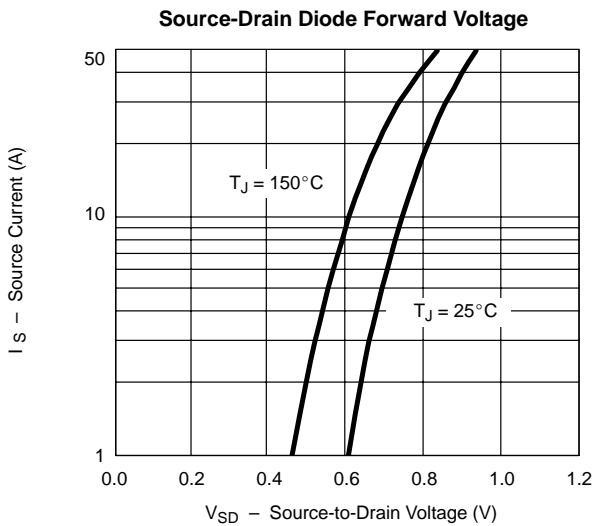
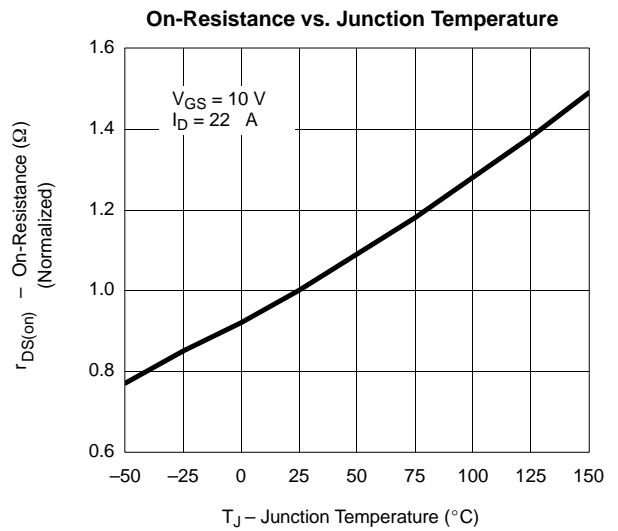
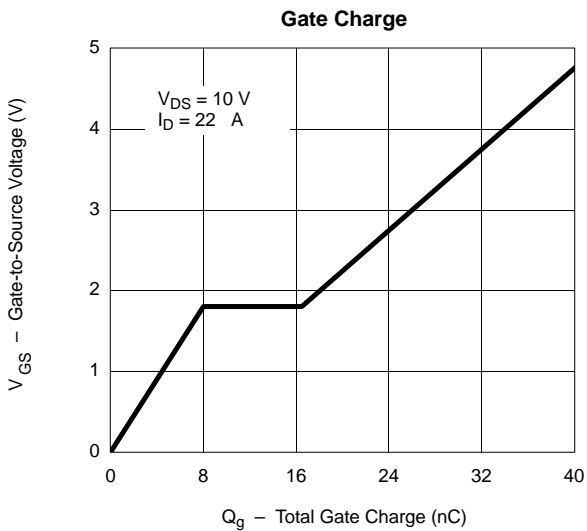
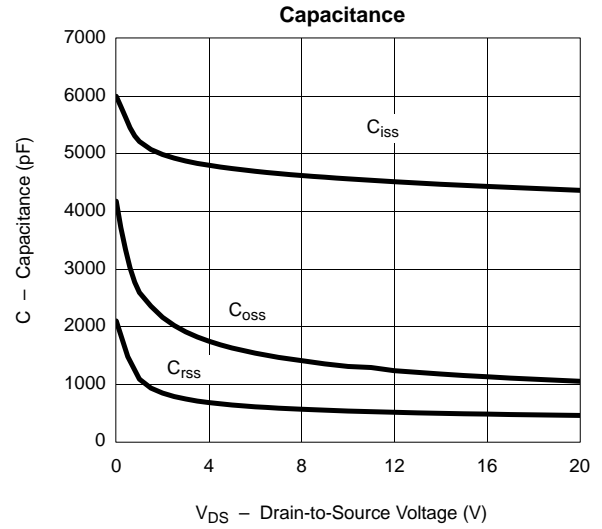
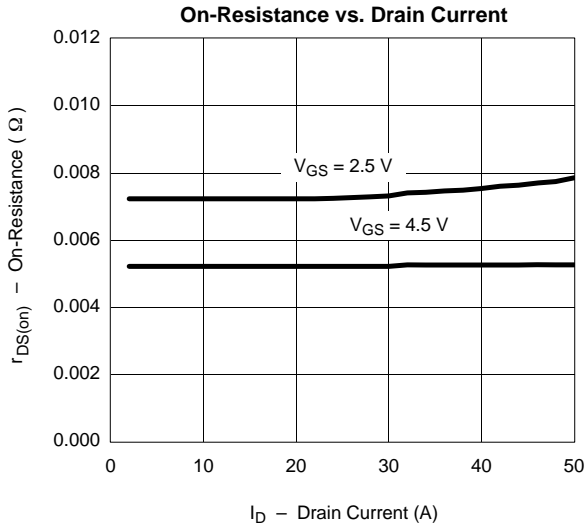
Notes

- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

